Notice of References Cited					Application/Control No. 09/116,124 Examiner		Applicant(s)/Patent Under Reexamination NISHINA ET AL. Art Unit		
							Page 1 of 1		
Hai Tran 2611 U.S. PATENT DOCUMENTS									
*		DOCUMENT NO.	DATE	NAME		CLASS	SUBCLASS	DOCUMENT SOURCE ** APS OTHER	
	Α	6005562	Dec. 1999	Shiga et al.		345	327		
	В	5675752	Oct 1997	Scott et al.		395	333		
	С	5850218	Dec 1998	LaJoie et al.		345	327		
	D	5795228	Aug 1998	Trumbull et al.		463	42		
	E	6011546	Jan 2000	Bertram		345	327		
Ď	F	5982445	Nov. 1999	Eyer et al.		348	461	0	
	G	6025837	Feb 2000	Matthews, III et al.		345	327		
	Ξ								
	ı					,		0	
	J						•		
	К								
	L								
	Μ								
		FOREIGN PATENT DOCUMENTS DOCUMENT							
*		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS	SOURCE	OTHER
	N								
	0	·	·						
	Р								
	Q	•							
	R			· · · · · · · · · · · · · · · · · · ·					
	s								
	Т								
NON-PATENT DOCUMENTS DOCUMENT									
*	DOCUMENT (Including Author, Title Date, Source, and Pertinent Pages)							SOURCE	OTHER
	U								
	V								
	w	1							0
	x	·							

\*A copy of this reference is not being furnished with this Office action. (See Manual of Patent Examining Procedure, Section 707.05(a).)

\*\*APS encompasses any electronic search i.e. text, image, and Commercial Databases.

U.S. Patent and Trademark Office
PTO-892 (Rev. 03-98)

Notice of References Cited